

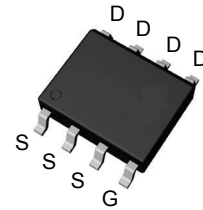
Features

- 100V/-6A
 $R_{DS(ON)}=150m\Omega(\text{typ.})@V_{GS}=-10V$
 $R_{DS(ON)}=180m\Omega(\text{typ.})@V_{GS}=-4.5V$
- 100% UIS + R_g Tested
- Reliable and Rugged
- Lead Free and Green Devices Available
(RoHS Compliant)

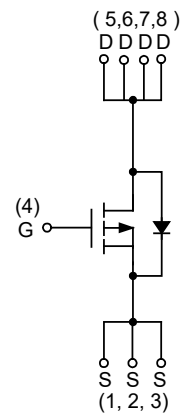
Applications

- Power Management in Desktop Computer or DC/DC Converters

Pin Description



SOP8



P-Channel MOSFET

Absolute Maximum Ratings ($T_A=25^{\circ}\text{C}$ Unless Otherwise Noted)

Symbol	Parameter		Rating	Unit
Common Ratings				
V _{DSS}	Drain-Source Voltage		-100	V
V _{GSS}	Gate-Source Voltage		±20	
T _J	Maximum Junction Temperature		150	°C
T _{STG}	Storage Temperature Range		-55 to 150	
I _S	Diode Continuous Forward Current	T _A =25°C	-6	A
I _D	Continuous Drain Current	T _A =25°C	-6	A
		T _A =70°C	-4.5	
I _{DM} ^a	Pulsed Drain Current	T _A =25°C	-18	
P _D	Maximum Power Dissipation	T _A =25°C	1.8	W
		T _A =70°C	1.1	
R _{θJA}	Thermal Resistance-Junction to Ambient		70	°C/W
I _{AS} ^b	Avalanche Current, Single pulse	L=0.5mH	-11	A
E _{AS} ^b	Avalanche Energy, Single pulse	L=0.5mH	30	mJ

Note a : Pulse width limited by maximum junction temperature.

Note b : UIS tested and pulse width limited by maximum junction temperature (initial temperature $T_J=25^{\circ}\text{C}$).

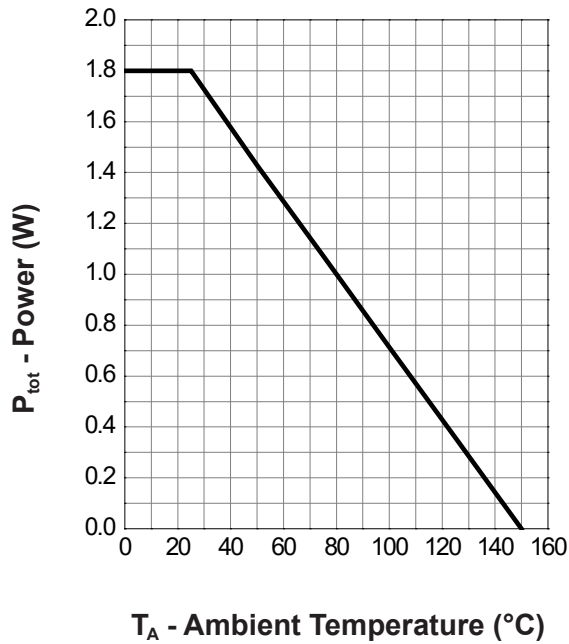
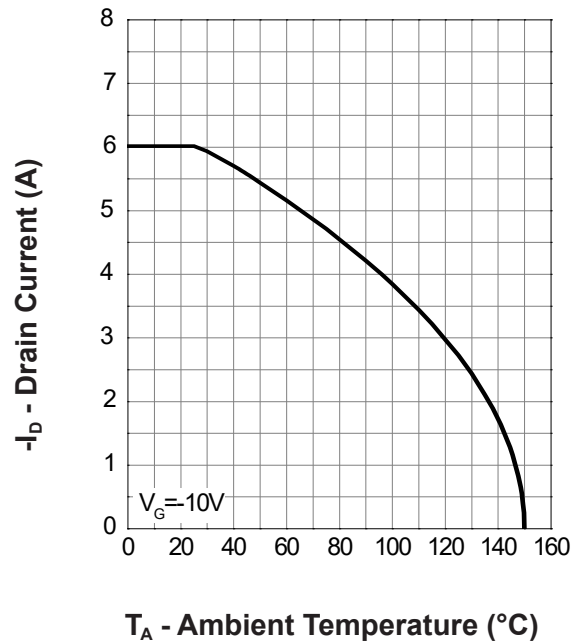
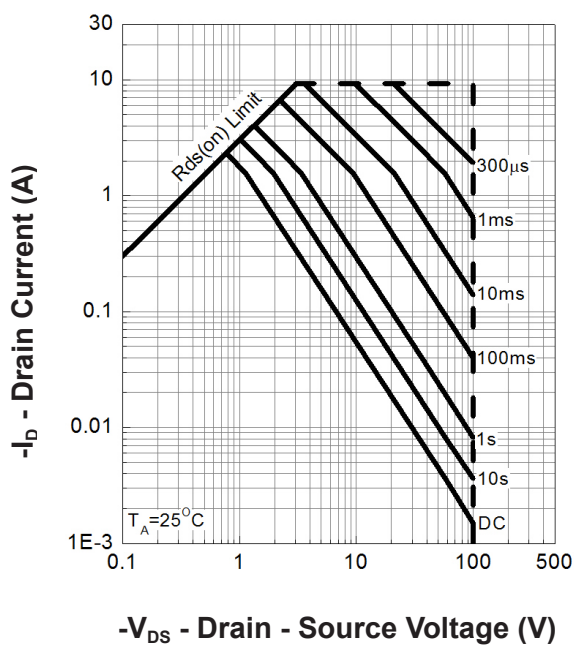
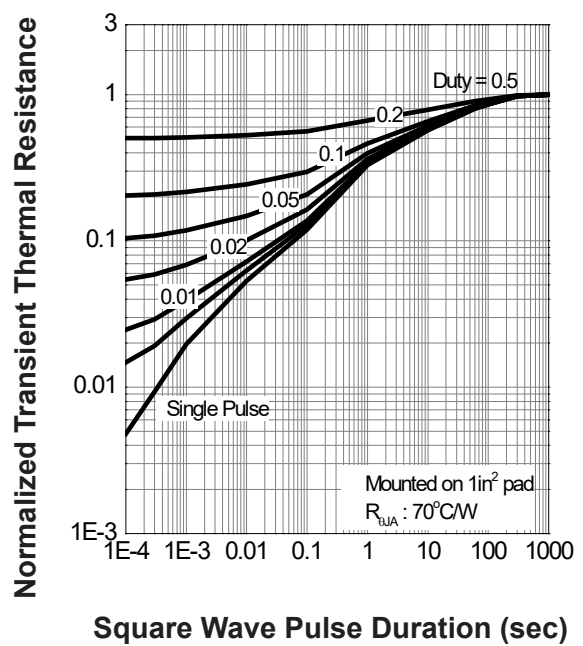
Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =-250μA	-100	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-80V, V _{GS} =0V T _J =85°C	-	-	-1	μA
			-	-	-30	
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =-250μA	-1	-1.8	-3	V
I _{GSS}	Gate Leakage Current	V _{GS} =±20V, V _{DS} =0V	-	-	±10	μA
R _{DS(ON)} ^c	Drain-Source On-state Resistance	V _{GS} =-10V, I _{DS} =-3.5A	-	150	195	mΩ
		V _{GS} =-4.5V, I _{DS} =-2.1A	-	180	250	mΩ
Diode Characteristics						
V _{SD} ^c	Diode Forward Voltage	I _{SD} =-1.7A, V _{GS} =0V	-	-0.75	-1.1	V
t _{rr} ^d	Reverse Recovery Time	I _{SD} =-3.5A, dI _{SD} /dt=100A/μs	-	33	-	ns
Q _{rr} ^d	Reverse Recovery Charge		-	46	-	nC
Dynamic Characteristics ^d						
R _G	Gate Resistance	V _{GS} =0V, V _{DS} =0V, F=1MHz	-	9	-	Ω
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =-50V, Frequency=1.0MHz	-	895	1163	pF
C _{oss}	Output Capacitance		-	55	-	
C _{rss}	Reverse Transfer Capacitance		-	34	-	
t _{d(ON)}	Turn-on Delay Time	V _{DD} =-30V, R _L =30Ω, I _{DS} =1A, V _{GEN} =10V, R _G =6Ω	-	10	18	ns
t _r	Turn-on Rise Time		-	5	9	
t _{d(OFF)}	Turn-off Delay Time		-	59	106	
t _f	Turn-off Fall Time		-	26	47	
Gate Charge Characteristics ^d						
Q _g	Total Gate Charge	V _{DS} =-50V, V _{GS} =-10V, I _{DS} =-3.5A	-	21	30	nC
Q _g	Total Gate Charge	V _{DS} =-50V, V _{GS} =-4.5V, I _{DS} =-3.5A	-	10.3	-	
Q _{gs}	Gate-Source Charge		-	3.2	-	
Q _{gd}	Gate-Drain Charge		-	4.7	-	

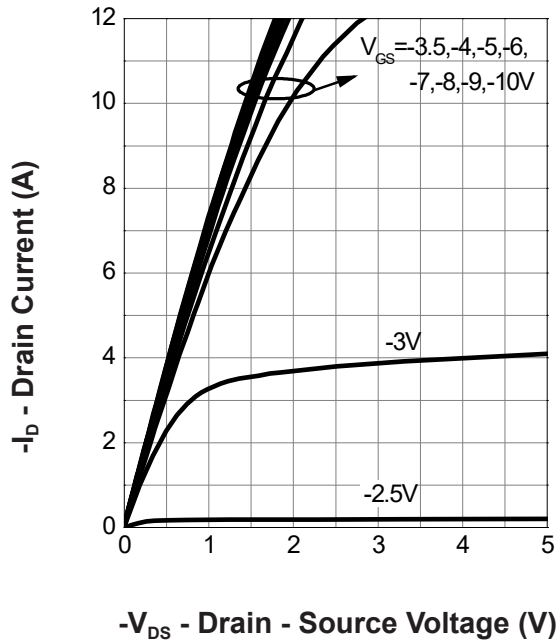
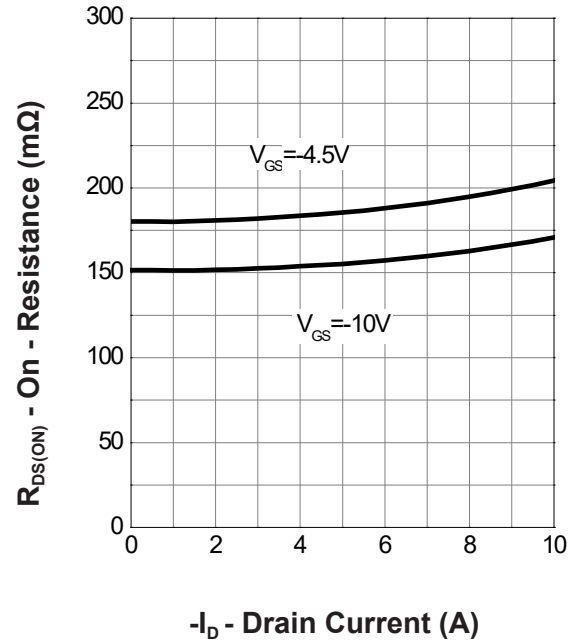
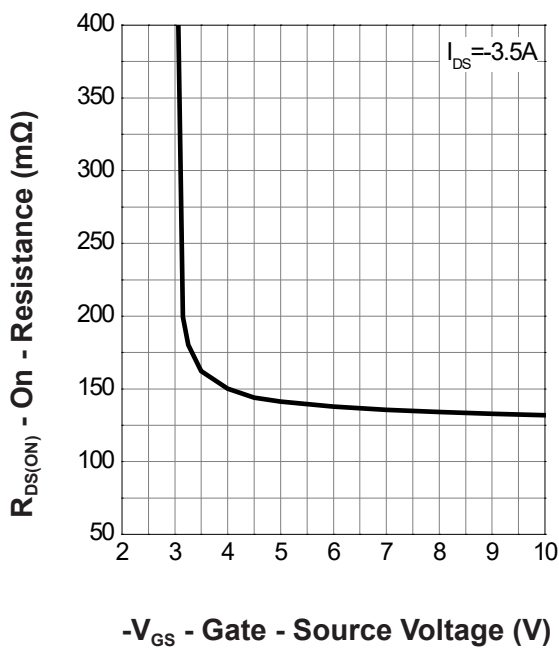
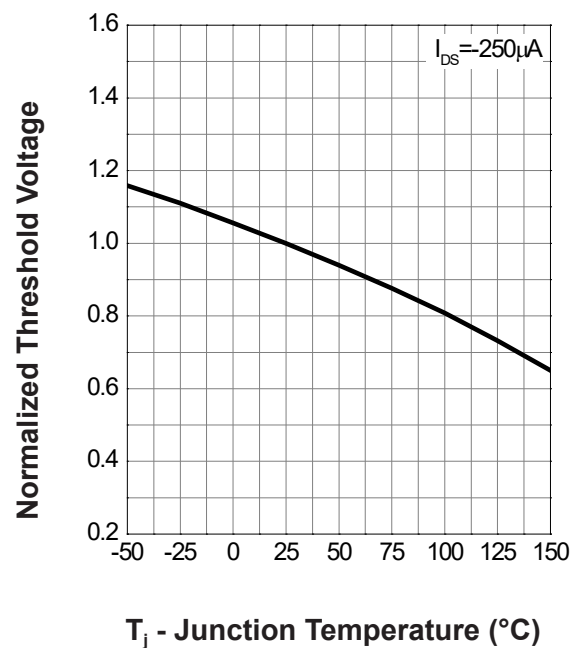
Note c : Pulse test ; pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.

Note d : Guaranteed by design, not subject to production testing.

Typical Operating Characteristics

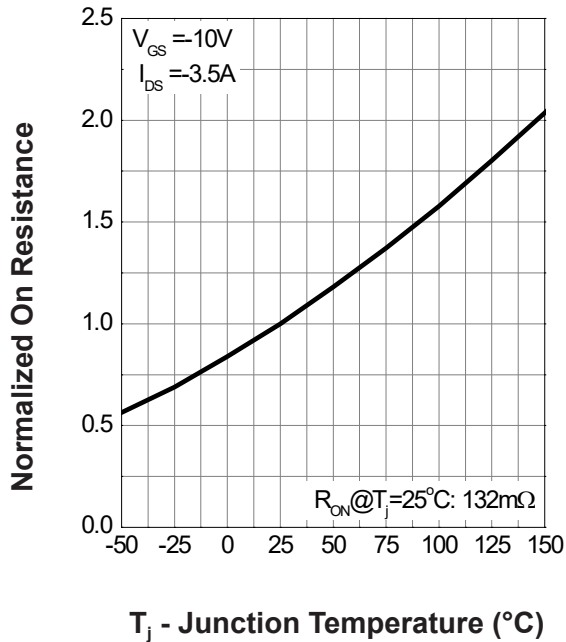
Power Dissipation

Drain Current

Safe Operation Area

Thermal Transient Impedance


Typical Operating Characteristics(Cont.)

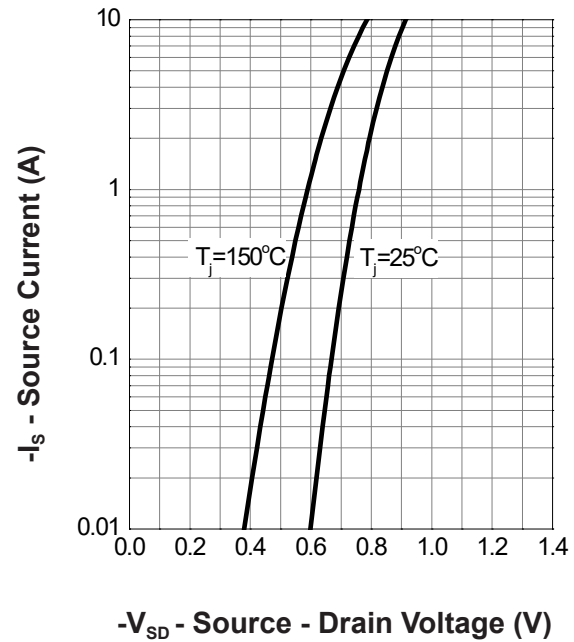
Output Characteristics

Drain-Source On Resistance

Gate-Source On Resistance

Gate Threshold Voltage


Typical Operating Characteristics(Cont.)

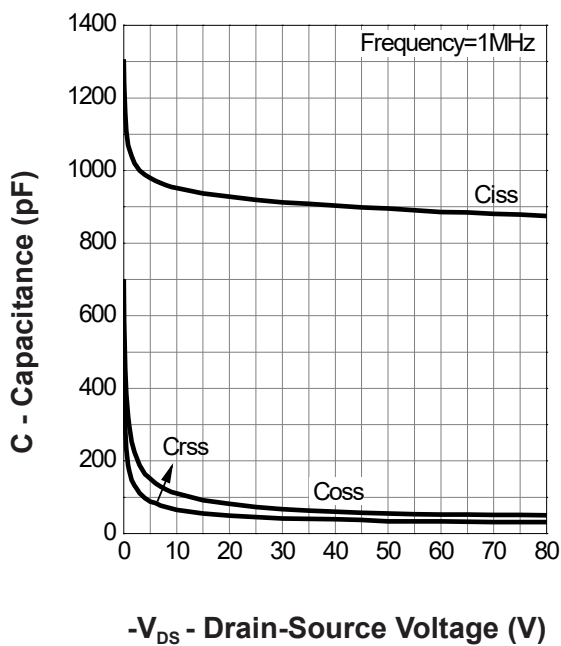
Drain-Source On Resistance



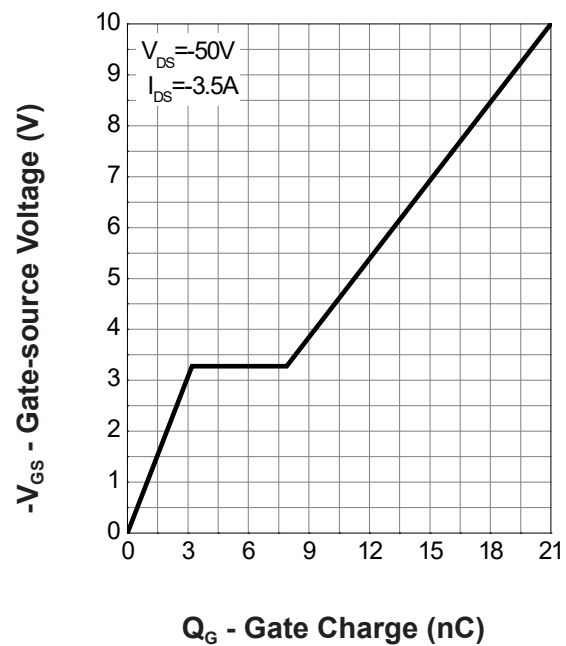
Source-Drain Diode Forward



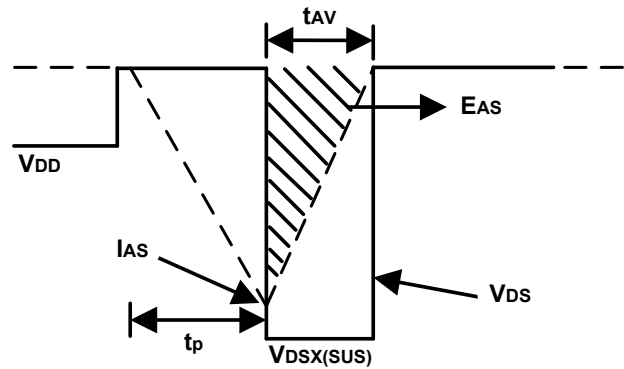
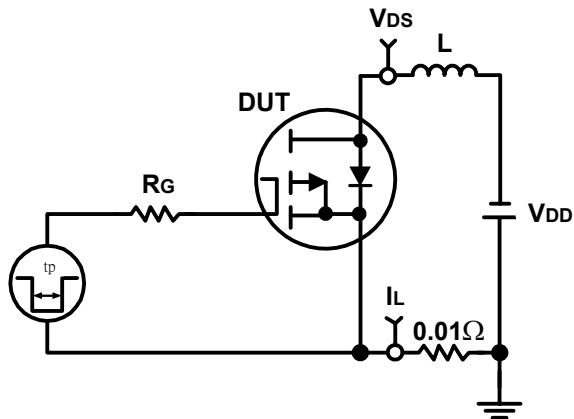
Capacitance



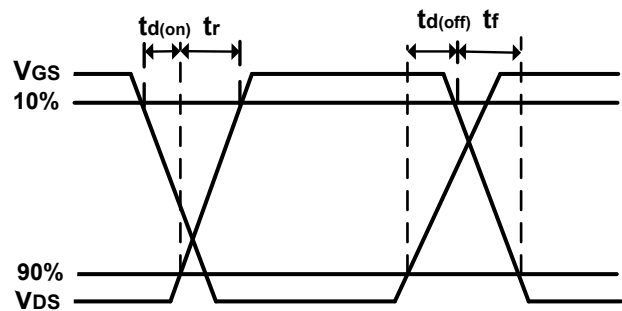
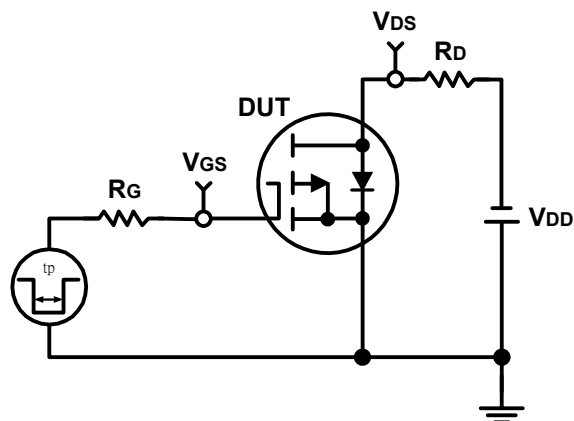
Gate Charge



Avalanche Test Circuit and Waveforms

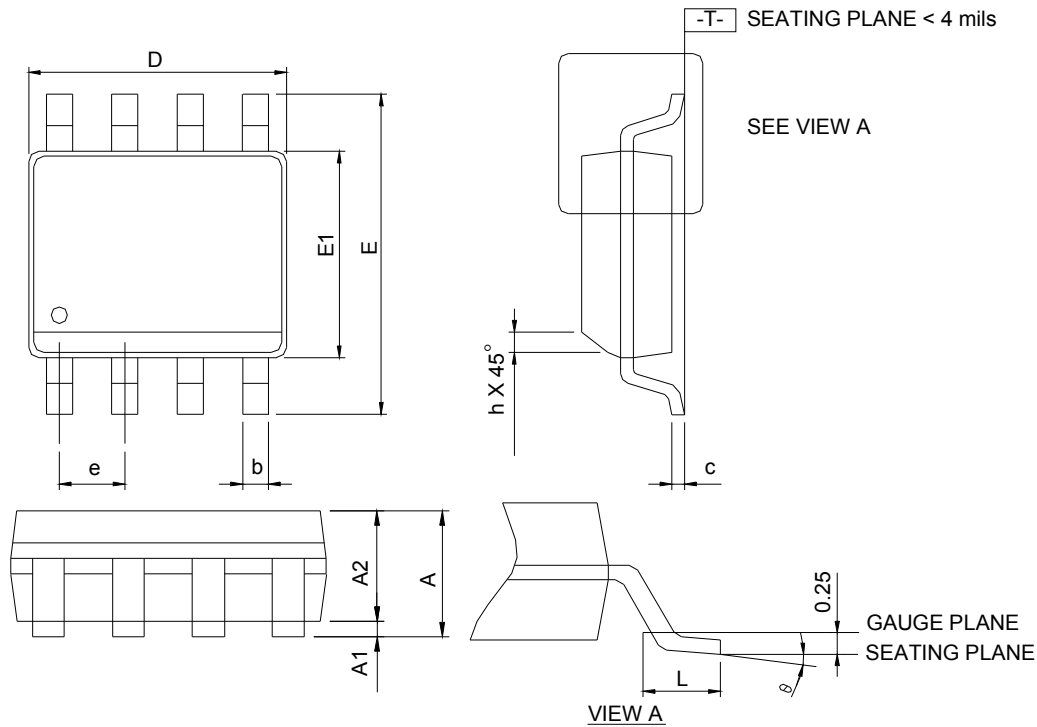


Switching Time Test Circuit and Waveforms



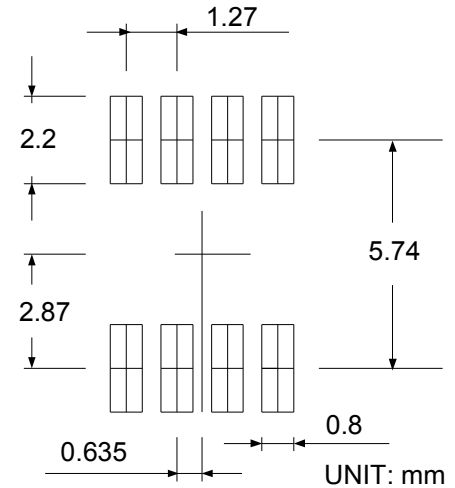
Package Information

SOP8



SYMBOL	SOP8			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	-	1.75	-	0.069
A1	0.10	0.25	0.004	0.010
A2	1.25	-	0.049	-
b	0.31	0.51	0.012	0.020
c	0.17	0.25	0.007	0.010
D	4.80	5.00	0.189	0.197
E	5.80	6.20	0.228	0.244
E1	3.80	4.00	0.150	0.157
e	1.27 BSC		0.050 BSC	
h	0.25	0.50	0.010	0.020
L	0.40	1.27	0.016	0.050
θ	0°	8°	0°	8°

RECOMMENDED LAND PATTERN



- Note: 1. Follow JEDEC MS-012 AA.
2. Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusion or gate burrs shall not exceed 6 mil per side.
3. Dimension "E" does not include inter-lead flash or protrusions. Inter-lead flash and protrusions shall not exceed 10 mil per side.